

## N-Channel Logic Level Enhancement Mode Field Effect Transistor

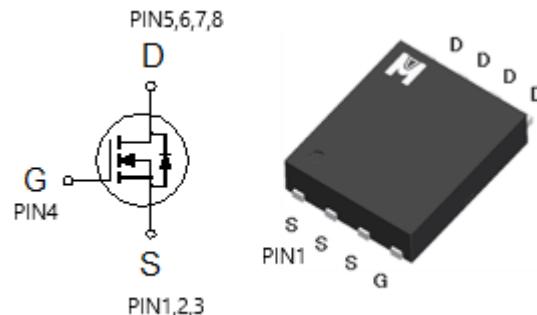
## Product Summary:

|   |                      |
|---|----------------------|
| $BV_{DSS}$                              | 30V                  |
| $R_{DS(on)}(\text{MAX.}) @ V_{GS}=10V$  | $7.5\text{m}\Omega$  |
| $R_{DS(on)}(\text{MAX.}) @ V_{GS}=4.5V$ | $10.5\text{m}\Omega$ |
| $I_D @ T_C=25^\circ\text{C}$            | 50A                  |

Single N Channel MOSFET

UIS,  $R_g$  100% Tested

RoHS &amp; Halogen Free &amp; TSCA Compliant

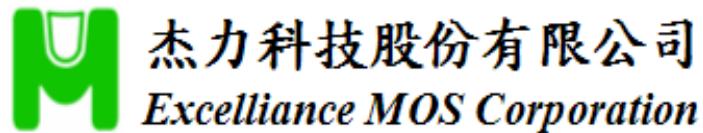
ABSOLUTE MAXIMUM RATINGS ( $T_C = 25^\circ\text{C}$  Unless Otherwise Noted)

| PARAMETERS/TEST CONDITIONS                     |                           | SYMBOL         | LIMITS     | UNIT |
|--|---------------------------|----------------|------------|------|
| Gate-Source Voltage                            |                           | $V_{GS}$       | $\pm 20$   | V    |
| Continuous Drain Current                       | $T_C = 25^\circ\text{C}$  | $I_D$          | 50         | A    |
|  | $T_C = 100^\circ\text{C}$ |                | 35         |      |
|  | $T_A = 25^\circ\text{C}$  |                | 12         |      |
|  | $T_A = 70^\circ\text{C}$  |                | 10         |      |
| Pulsed Drain Current <sup>1</sup>              |                           | $I_{DM}$       | 140        |      |
| Avalanche Current                              |                           | $I_{AS}$       | 37.5       |      |
| Avalanche Energy                               | $L = 0.1\text{mH}$        | $E_{AS}$       | 70         | mJ   |
| Repetitive Avalanche Energy <sup>2</sup>       | $L = 0.05\text{mH}$       | $E_{AR}$       | 35         |      |
| Power Dissipation                              | $T_C = 25^\circ\text{C}$  | $P_D$          | 50         | W    |
|  | $T_C = 100^\circ\text{C}$ |                | 20         |      |
| Operating Junction & Storage Temperature Range |                           | $T_j, T_{stg}$ | -55 to 150 | °C   |

100% UIS testing in condition of  $V_D=25V$ ,  $L=0.1\text{mH}$ ,  $V_G=10V$ ,  $I_L=25A$ , Rated  $V_{DS}=30V$  N-CH

## THERMAL RESISTANCE RATINGS

| THERMAL RESISTANCE               | SYMBOL          | TYPICAL | MAXIMUM | UNIT   |
|----------------------------------|-----------------|---------|---------|--------|
| Junction-to-Case                 | $R_{\theta JC}$ | 2.5     | 50      | °C / W |
| Junction-to-Ambient <sup>3</sup> | $R_{\theta JA}$ |         |         |        |



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<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>Duty cycle < 1%

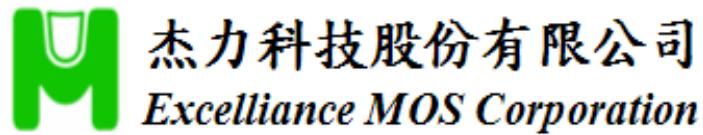
<sup>3</sup>The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz.

Copper, in a still air environment with  $T_A = 25^\circ C$ .

<sup>4</sup>Guarantee by Engineering test

ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ , Unless Otherwise Noted)

| PARAMETER   | SYMBOL                           | TEST CONDITIONS  | LIMITS |      |           | UNIT             |
|---|----------------------------------|--|--------|------|-----------|------------------|
|   |                                  |  | MIN    | TYP  | MAX       |                  |
| STATIC  |                                  |  |        |      |           |                  |
| Drain-Source Breakdown Voltage  | $V_{(\text{BR})\text{DSS}}$      | $V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$  | 30     |      |           | V                |
| Gate Threshold Voltage  | $V_{\text{GS}(\text{th})}$       | $V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$                                    | 1.4    | 2.0  | 3.0       |                  |
| Gate-Body Leakage   | $I_{\text{GSS}}$                 | $V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 20\text{V}$                              |        |      | $\pm 100$ | nA               |
| Zero Gate Voltage Drain Current   | $I_{\text{DSS}}$                 | $V_{\text{DS}} = 24\text{V}, V_{\text{GS}} = 0\text{V}$                                  |        |      | 1         | $\mu\text{A}$    |
|   |                                  | $V_{\text{DS}} = 20\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$         |        |      | 25        |                  |
| On-State Drain Current <sup>1</sup>   | $I_{\text{D}(\text{ON})}$        | $V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 10\text{V}$                                 | 50     |      |           | A                |
| Drain-Source On-State Resistance <sup>1</sup>                               | $R_{\text{DS}(\text{ON})}$       | $V_{\text{GS}} = 10\text{V}, I_D = 25\text{A}$   |        | 6    | 7.5       | $\text{m}\Omega$ |
|   |                                  | $V_{\text{GS}} = 4.5\text{V}, I_D = 20\text{A}$  |        | 8    | 10.5      |                  |
| Forward Transconductance <sup>1</sup>                                       | $g_{\text{fs}}$                  | $V_{\text{DS}} = 5\text{V}, I_D = 20\text{A}$  |        | 18   |           | S                |
| DYNAMIC   |                                  |  |        |      |           |                  |
| Input Capacitance   | $C_{\text{iss}}$                 | $V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 15\text{V}, f = 1\text{MHz}$                 |        | 1014 |           | pF               |
| Output Capacitance  | $C_{\text{oss}}$                 |  |        | 163  |           |                  |
| Reverse Transfer Capacitance  | $C_{\text{rss}}$                 |  |        | 93   |           |                  |
| Gate Resistance   | $R_g$                            | $V_{\text{GS}} = 15\text{mV}, V_{\text{DS}} = 0\text{V}, f = 1\text{MHz}$                |        | 2.2  |           | $\Omega$         |
| Total Gate Charge <sup>1,2</sup>  | $Q_g(V_{\text{GS}}=10\text{V})$  | $V_{\text{DS}} = 15\text{V}, V_{\text{GS}} = 10\text{V}, I_D = 25\text{A}$               |        | 15   |           | nC               |
|   | $Q_g(V_{\text{GS}}=4.5\text{V})$ |  |        | 8.5  |           |                  |
| Gate-Source Charge <sup>1,2</sup>   | $Q_{\text{gs}}$                  |  |        | 3.3  |           |                  |
| Gate-Drain Charge <sup>1,2</sup>  | $Q_{\text{gd}}$                  |  |        | 3.5  |           |                  |
| Turn-On Delay Time <sup>1,2</sup>   | $t_{\text{d}(\text{on})}$        | $V_{\text{DS}} = 15\text{V}, I_D = 5\text{A}, V_{\text{GS}} = 10\text{V}, R_G = 3\Omega$ |        | 7.1  |           | nS               |
| Rise Time <sup>1,2</sup>  | $t_r$                            |  |        | 14.5 |           |                  |
| Turn-Off Delay Time <sup>1,2</sup>  | $t_{\text{d}(\text{off})}$       |  |        | 28.1 |           |                  |
| Fall Time <sup>1,2</sup>  | $t_f$                            |  |        | 19.9 |           |                  |
| SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ( $T_C = 25^\circ\text{C}$ ) |                                  |  |        |      |           |                  |
| Continuous Current  | $I_s$                            | $I_F = I_s, V_{\text{GS}} = 0\text{V}$   |        |      | 50        | A                |
| Pulsed Current <sup>3</sup>   | $I_{\text{SM}}$                  |  |        |      | 140       |                  |
| Forward Voltage <sup>1</sup>  | $V_{\text{SD}}$                  |  |        |      | 1.3       |                  |
| Reverse Recovery Time   | $t_{\text{rr}}$                  | $I_F = I_s, dI_F/dt = 100\text{A} / \mu\text{s}$   |        | 20   |           | nS               |
| Peak Reverse Recovery Current   | $I_{\text{RM}(\text{REC})}$      |  |        | 180  |           |                  |
| Reverse Recovery Charge   | $Q_{\text{rr}}$                  |  |        | 11   |           |                  |



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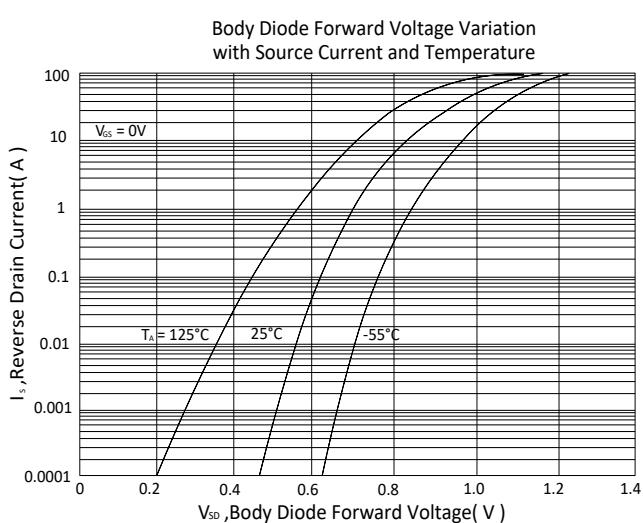
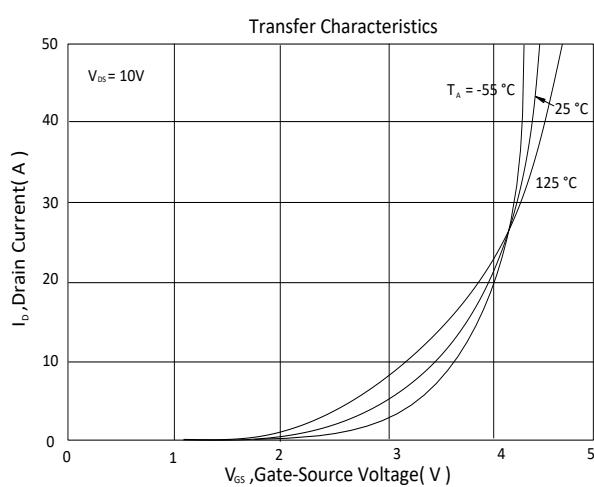
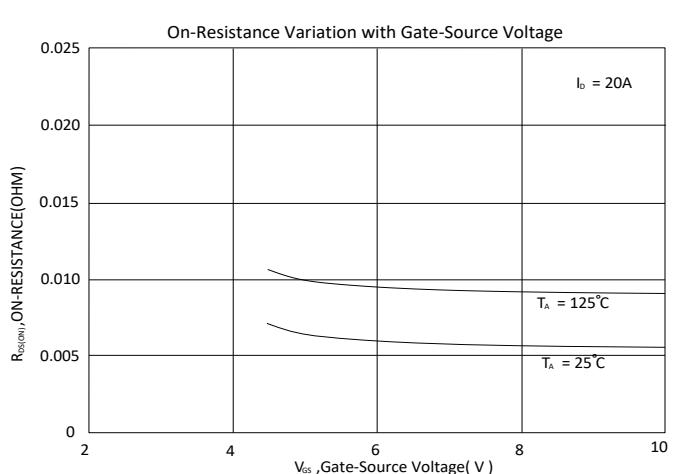
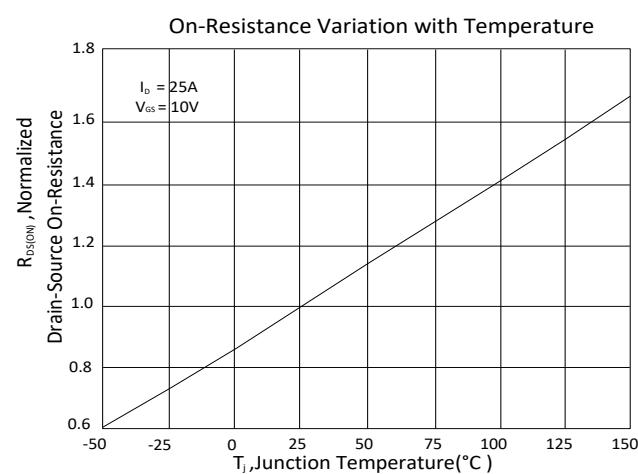
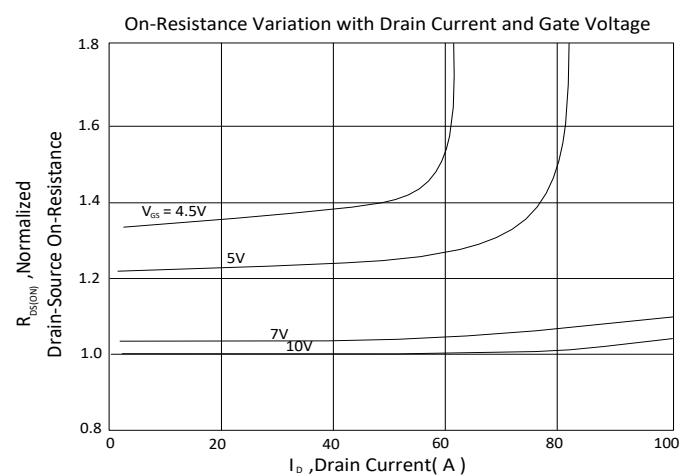
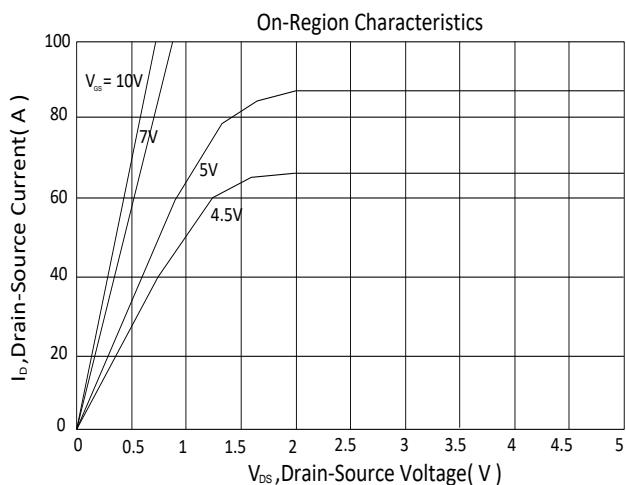
<sup>1</sup>Pulse test : Pulse Width  $\leq$  300  $\mu$ sec, Duty Cycle  $\leq$  2%.

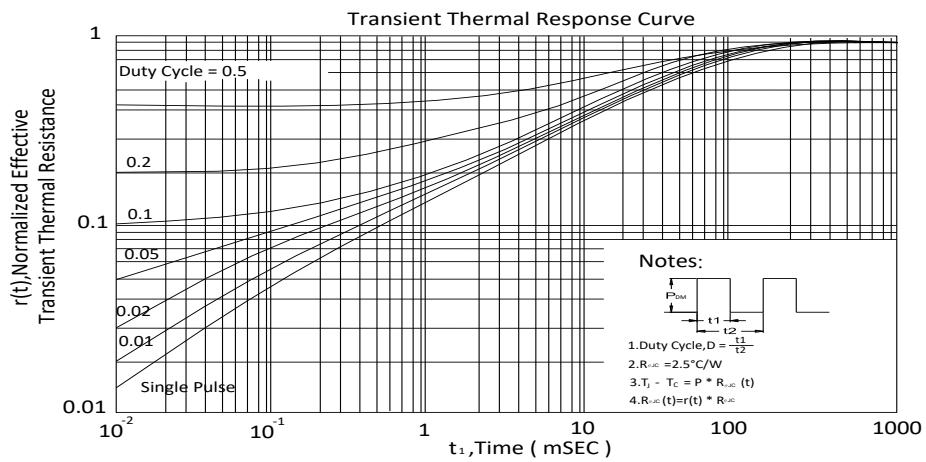
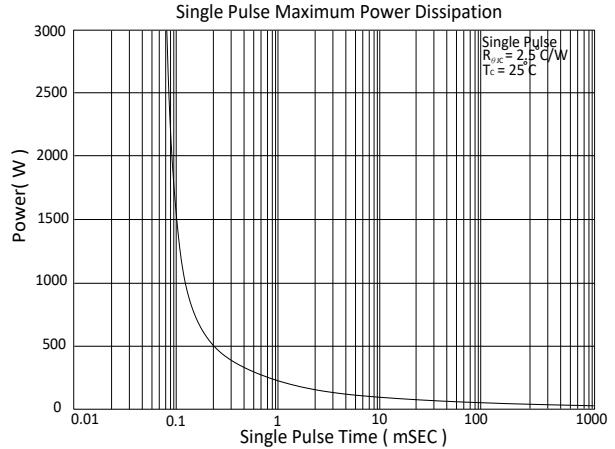
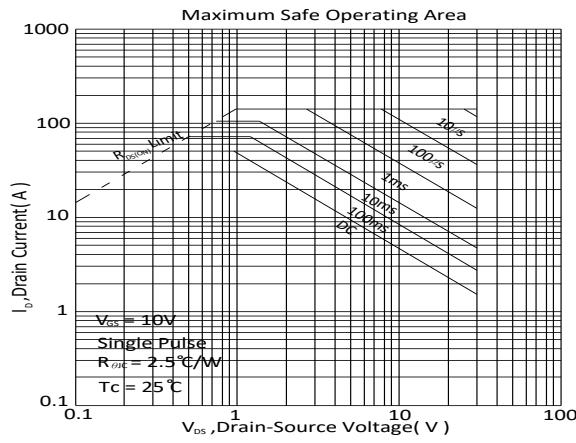
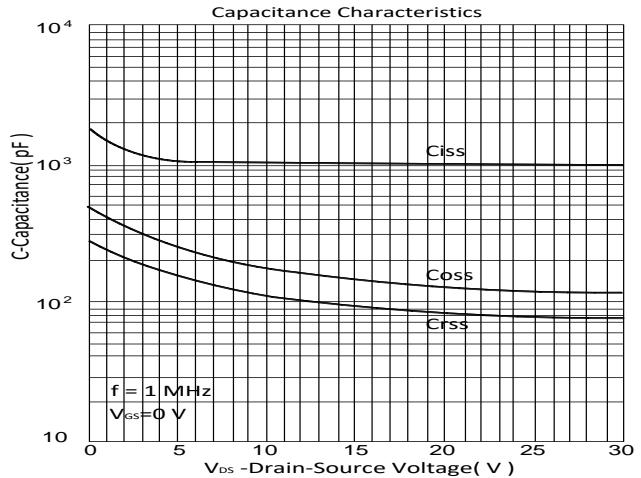
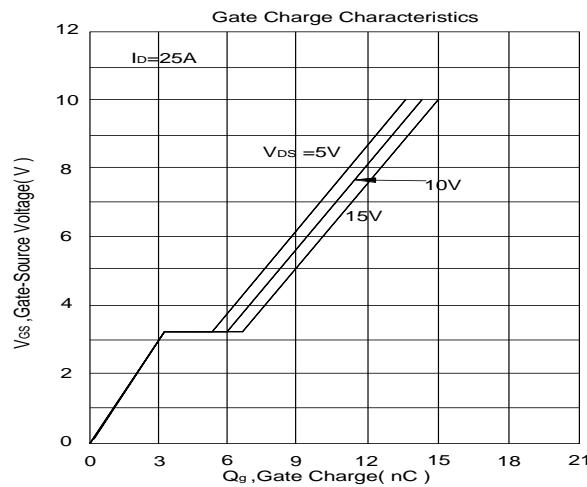
<sup>2</sup>Independent of operating temperature.

<sup>3</sup>Pulse width limited by maximum junction temperature.

EMC will review datasheet by quarter, and update new version.

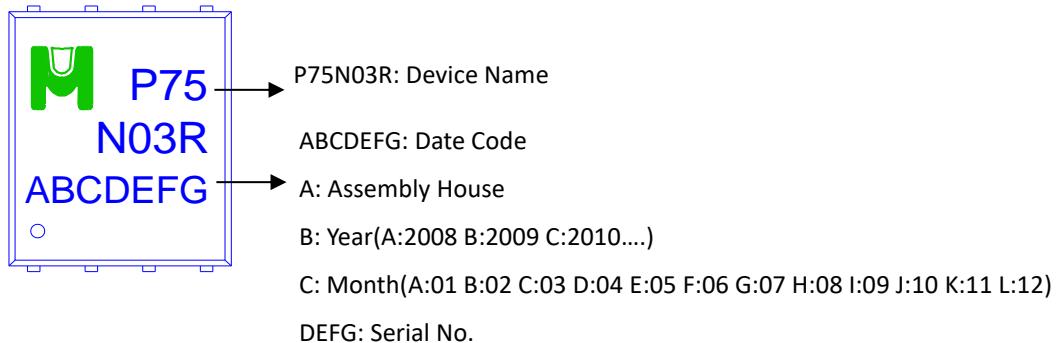
TYPICAL CHARACTERISTICS



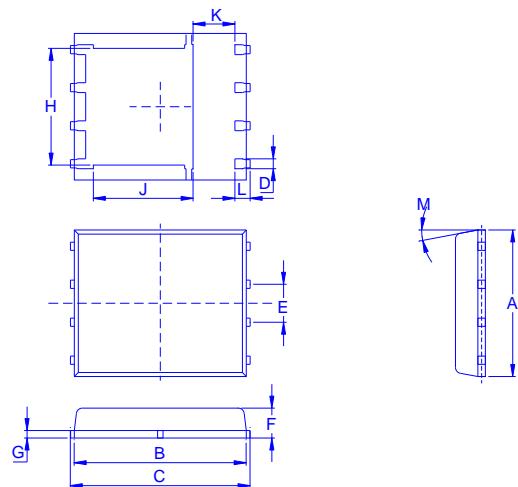


### Ordering & Marking Information:

Device Name: EMP75N03HR for EDFN5X6



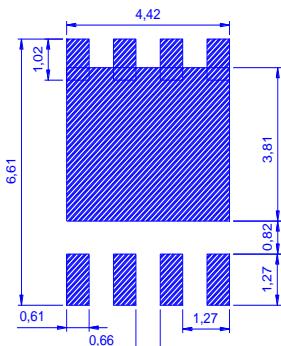
### Outline Drawing



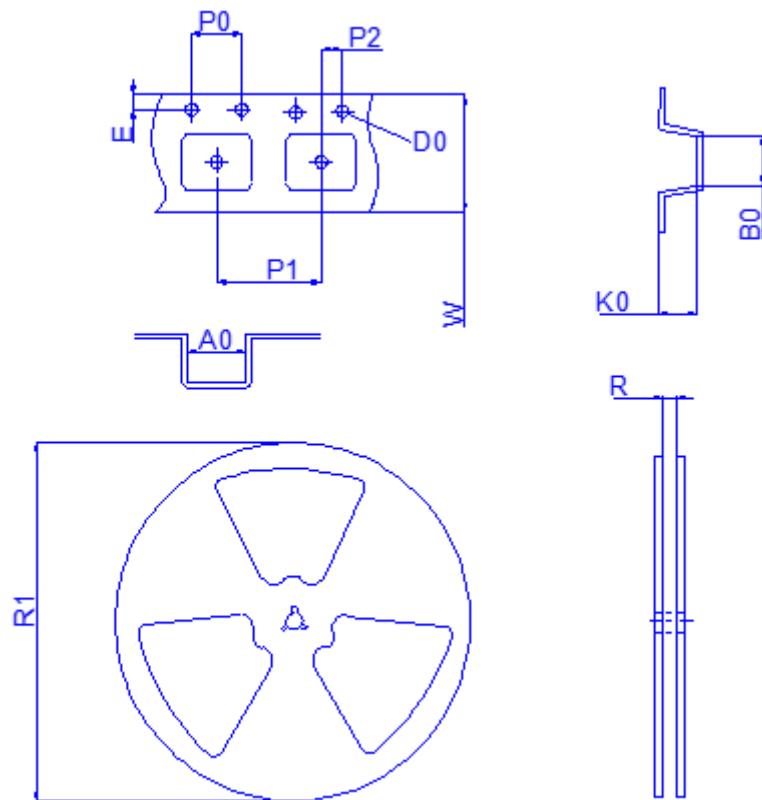
### Dimension in mm

| Dimension | A   | B    | C    | D    | E    | F    | G    | H    | J    | K    | L    | M   |
|-----------|-----|------|------|------|------|------|------|------|------|------|------|-----|
| Min       | 4.8 | 5.55 | 5.9  | 0.3  | 1.17 | 0.85 | 0.15 | 3.61 | 3.18 | 1    | 0.38 | 0°  |
| Typ.      | 4.9 | 5.7  | 6    | 0.4  | 1.27 | 0.95 | 0.2  | 3.87 | 3.44 | 1.2  | 0.4  |     |
| Max       | 5.4 | 5.85 | 6.15 | 0.51 | 1.37 | 1.17 | 0.34 | 4.31 | 3.78 | 1.39 | 0.71 | 12° |

### Recommended minimum pads



- ◆ Tape&Reel Information: 2500pcs/Reel(Dimension in millimeter)



|                    |                        |
|--------------------|------------------------|
| Package            | EDFN5X6                |
| Reel               | 13"                    |
| Device orientation | FEED DIRECTION<br><br> |

Dimension in mm

| Dimension | Carrier tape |     |     |     |     |     |     |     | Reel |      |     |
|-----------|--------------|-----|-----|-----|-----|-----|-----|-----|------|------|-----|
|           | A0           | B0  | D0  | E   | K0  | P0  | P1  | P2  | W    | R    | R1  |
| Typ.      | 6.4          | 5.3 | 1.5 | 1.8 | 1.6 | 4   | 8   | 2   | 12   | 12.4 | 330 |
| ±         | 0.2          | 0.2 | 0.1 | 0.1 | 0.6 | 0.1 | 0.1 | 0.1 | 0.3  | 2    | 2   |